

6501122 NATIONAL SEMICONDUCTOR

86D 56337 DT-51-21



## DM54LS37/DM74LS37 Quad 2-Input NAND Buffers

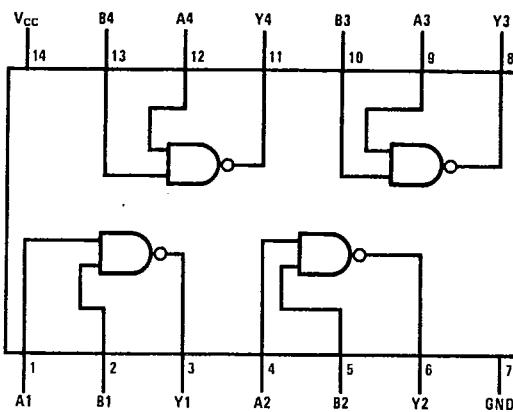
### General Description

This device contains four independent buffer gates each of which performs the logic NAND function.

DM54LS37/DM74LS37

### Connection Diagram

Dual-In-Line Package



TL/F/6362-1

Order Number DM54LS37J, DM74LS37M or DM74LS37N  
See NS Package Number J14A, M14A or N14A

### Function Table

$$Y = \overline{AB}$$

Inputs		Output
A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L

H = High Logic Level

L = Low Logic Level

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DM54LS37/DM74LS37

**Absolute Maximum Ratings** (Note)

Specifications for Military/Aerospace products are not contained in this datasheet. Refer to the associated reliability electrical test specifications document.

Supply Voltage	7V
Input Voltage	7V
Operating Free Air Temperature Range	-55°C to +125°C DM54LS 0°C to +70°C DM74LS
Storage Temperature Range	-65°C to +150°C

Note: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the "Electrical Characteristics" table are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

**Recommended Operating Conditions**

Symbol	Parameter	DM54LS37			DM74LS37			Units
		Min	Nom	Max	Min	Nom	Max	
V <sub>CC</sub>	Supply Voltage	4.5	5	5.5	4.75	5	5.25	V
V <sub>IH</sub>	High Level Input Voltage	2			2			V
V <sub>IL</sub>	Low Level Input Voltage			0.7			0.8	V
I <sub>OH</sub>	High Level Output Current			-1.2			-1.2	mA
I <sub>OL</sub>	Low Level Output Current			12			24	mA
T <sub>A</sub>	Free Air Operating Temperature	-55		125	0		70	°C

**Electrical Characteristics** over recommended operating free air temperature range (unless otherwise noted)

Symbol	Parameter	Conditions		Min	Typ (Note 1)	Max	Units
V <sub>I</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>I</sub> = -18 mA				-1.5	V
V <sub>OH</sub>	High Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OH</sub> = Max V <sub>IL</sub> = Max	DM54	2.5	3.4		V
			DM74	2.7	3.4		
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = Max V <sub>IH</sub> = Min	DM54		0.25	0.4	V
			DM74		0.35	0.5	
		I <sub>OL</sub> = 12 mA, V <sub>CC</sub> = Min	DM74		0.25	0.4	
I <sub>I</sub>	Input Current @ Max Input Voltage	V <sub>CC</sub> = Max, V <sub>I</sub> = 7V				0.1	mA
I <sub>IH</sub>	High Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 2.7V				20	μA
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 0.4V				-0.36	mA
I <sub>OS</sub>	Short Circuit Output Current	V <sub>CC</sub> = Max (Note 2)	DM54	-20		-100	mA
			DM74	-20		-100	
I <sub>CCH</sub>	Supply Current with Outputs High	V <sub>CC</sub> = Max			0.9	2	mA
I <sub>CCL</sub>	Supply Current with Outputs Low	V <sub>CC</sub> = Max			6	12	mA

**Switching Characteristics** at V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C (See Section 1 for Test Waveforms and Output Load)

Symbol	Parameter	R <sub>L</sub> = 667Ω				Units	
		C <sub>L</sub> = 45 pF		C <sub>L</sub> = 150 pF			
		Min	Max	Min	Max		
t <sub>PLH</sub>	Propagation Delay Time Low to High Level Output	3	15	4	18	ns	
t <sub>PHL</sub>	Propagation Delay Time High to Low Level Output	3	15	4	21	ns	

Note 1: All typicals are at V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C.

Note 2: Not more than one output should be shorted at a time, and the duration should not exceed one second.